Lanthanum Nickel Silicides with the General Formula $\text{La}_{(n+1)(n+2)}\text{Ni}_{n(n-1)+2}\text{Si}_{n(n+1)}$ **and Other Series of Hexagonal Structures with Metal:Metalloid Ratios Close to 2:1**

Yurij M. Prots' and Wolfgang Jeitschko*

Anorganisch-Chemisches Institut, Universität Münster, Wilhelm-Klemm-Strasse 8, D-48149 Münster, Germany

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The closely related crystal structures of the compounds $La_6Ni_2Si_3 (La_{12}Ni_4Si_6, n = 2)$ and $La_5Ni_2Si_3 (La_{20}Ni_8Si_{12}, n = 2)$ $n = 3$) as well as those of the new compounds $La_{15}Ni_{7}Si_{10} (La_{30}Ni_{14}Si_{20}, n = 4)$ and $La_{21}Ni_{11}Si_{15} (La_{42}Ni_{22}Si_{30}, n = 4)$ $n = 5$) were determined from single-crystal X-ray diffractometer data. In these hexagonal silicides (space group *P*63/*m*) almost all atoms are situated on mirror planes, which extend perpendicular to the short *c* axes. The only exceptions are nickel atoms located on the $6₃$ axes, which show some disorder resulting in the exact compositions La₆Ni_{1.54(2)}Si₃ [*a* = 1224.3(1) pm, *c* = 438.3(1) pm, *Z* = 2, Ce₆Ni₂Si₃ type structure], La₅Ni_{1.75(1)}Si₃ [*a* = 1624.4(3) pm, $c = 434.2(2)$ pm, $Z = 4$, Ce₅Ni₂Si₃ type], La₁₅Ni_{6.62(2)}Si₁₀ [$a = 2021.2(3)$ pm, $c = 435.1(1)$ pm, $Z = 2$, $Pr_{15}Ni_7Si_{10}$ type], and $La_{21}Ni_{10.49(3)}Si_{15}$ [$a = 2427.7(3)$ pm, $c = 435.2(1)$ pm, $Z = 2$, a new structure type]. All of these structures have building elements which resemble the AlB2 type structure. In these the lanthanum atoms correspond to the aluminum atoms of AlB2, while the nickel and silicon atoms occupy the boron positions in an ordered manner. Other series of ternary hexagonal lanthanoid and actinoid transition metal silicides and phosphides, e.g., the series with the general formula $R_{n(n-1)}$ Ni_{(*n*+1)(*n*+2)P_{*n*(*n*+1)+1} ($R = Th$, U), are briefly reviewed, and the} systematics in the space groups and the diffraction patterns of these compounds are pointed out.

Introduction

More than 20 years ago a series of related cerium nickel silicides "Ce₂NiSi", "Ce₁₅Ni₄Si₁₃", and Ce₆Ni₂Si₃ were synthesized by Bodak and Gladyshevskii.¹⁻³ The general formula for these compounds was given as $Ce_{n^2+3n+2}(Ni, Si)_{2n^2+2}$, since at that time-when structures were determined from film data-it was generally believed that nickel and silicon can substitute for each other in such compounds. Later, when the crystal structures of such compounds were determined from diffractometer data, it was recognized that frequently the late transition metal and the silicon atoms order. Hovestreydt and Parthé⁴ reported the compound $Pr_{15}Ni_7Si_{10}$ with an ordered distribution of the nickel and silicon atoms, and they suggested "Ce₁₅Ni₄- $Si₁₃$ " to be isotypic with $Pr₁₅Ni₇Si₁₀$. They also gave a formula for this series of compounds accounting for the ordered distribution of the nickel and silicon atoms, which corresponds to the formula $R_{(n+1)(n+2)}$ Ni_{n(n-1)+2}Si_{n(n+1)} used in the present paper. We report on four compounds of this series of structures with lanthanum as the rare earth metal component with $n = 2$, 3, 4, and 5. For the previously published compounds " $La₂$ -NiSi"¹ and $La_6Ni_2Si_3{}^3$ we verify that the nickel and silicon atoms are ordered. The ideal formula for "La₂NiSi" is La₅Ni₂-Si₃ ($n = 3$), whereas the formula La₆Ni₂Si₃ ($n = 2$) remains correct. The other two compounds $La₁₅Ni₇Si₁₀$ (*n* = 4) and $La₂₁Ni₁₁Si₁₅$ ($n = 5$) are new. The latter crystallizes with a

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- (2) Mys'kiv, M. G.; Bodak, O. I.; Gladyshevskii, E. I. *So*V*. Phys. Crystallogr.* **1974**, *18*, 450. (3) Bodak, O. I.; Gladyshevskii, E. I.; Kharchenko, O. I. *So*V*. Phys.*
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- (4) Hovestreydt, E.; Parthe´, E. *Acta Crystallogr.* **1985**, *C41*, 310.

new structure type. A preliminary account of this work was presented at a conference.5

Preparation, Lattice Constants, and Properties

All compounds were prepared by reaction of the elemental components (lanthanum ingots, nominal purity 99.9%; nickel powder, 150 mesh, 99.9%, pressed to pellets; silicon pieces, 6N) in an arc-melting furnace under an argon atmosphere. The samples were turned over and remelted twice to enhance their homogeneity. They were then sealed in evacuated silica tubes, annealed for 2 weeks at 800 °C, and quenched in water.

The Guinier powder diagrams of the samples were compared to those calculated 6 for possible structure types with related compositions. This way it was recognized that the compounds $La_6Ni_{2-x}Si_3$, $La_5Ni_{2-x}Si_3$, and $La₁₅Ni_{7-x}Si₁₀$ were isotypic with the structures first described for $Ce₆Ni₂Si₃³ "Ce₂NiSi'₁¹ and Pr₁₅Ni₇Si₁₀⁴ Knowing the ideal composi$ tions from the structure determinations, we could prepare the compounds in nearly pure form by reaction of stoichiometric amounts of the elemental components. After we recognized that these compounds form a homologous series, a model for the structure of $La₂₁Ni₁₁Si₁₅$ was extrapolated, and single crystals of this predicted compound could be isolated from a sample with the ideal composition.

The lattice constants of these four compounds (Table 1) were obtained by least-squares fits of the Guinier powder data recorded at room temperature with Cu K α radiation using α -quartz (*a* = 491.30) pm, $c = 540.46$ pm) as an internal standard.

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Table 1. Crystal Data for $La_6Ni_{2-x}Si_3$, $La_5Ni_{2-x}Si_3$, $La_{15}Ni_{7-x}Si_{10}$, and $La_{21}Ni_{11-x}Si_{15}^a$

^a Standard deviations in the positions of the least significant digits are given in parentheses throughout the paper. *^b* Lattice parameters calculated from Guinier powder data, using α -quartz (*a* = 491.30 pm, *c* = 540.46 pm) as standard. The residuals are defined as follows: $R = (\sum |F_0 - F_1|)$ $|F_c|$)/ ΣF_0 ; $R_w = [\Sigma w[(F_0 - |F_c|)^2/\Sigma w(F_0)^2]^{1/2}$, $w = 4F^2/[\sigma(I)^2 + (0.04F^2)^2]^{1/2}$. ^c The corresponding Pearson symbols⁷ are *hP26*–4.92, *hP44*–5.00, *hP68–4.76* and *hP98*–5.02, respectively *hP*68-4.76, and *hP*98-5.02, respectively.

Well-crystallized samples of the four compounds have gray color and metallic luster, like elemental silicon. The powders are black. They deteriorate in air within a few days.

Structure Determinations

Single-crystals of the four compounds were isolated from arcmelted, annealed, crushed buttons. They had the shape of needles with the (short) hexagonal *c* axis as the preferred growth direction.

The hexagonal cells found from the Guinier powder data of $La₅Ni_{2-x}Si₃$ and $La₂₁Ni_{11-x}Si₁₅$ were confirmed by recording the reciprocal lattice in a Weissenberg camera. Single-crystal X-ray intensity data for all four compounds were collected at room temperature on Enraf-Nonius CAD4 diffractometers with *κ* geometry using graphite-monochromated Mo Κα radiation and a scintillation counter with pulse-height discrimination. The scans were along *θ* with background counts at both ends of each scan. Absorption corrections were made from *ψ*-scan data. The crystallographic data are summarized in Table 1 and in more detail in tables of the Supporting Information.

The structures were determined and refined with the SHELX-TL PLUS program package.⁸ The final least-squares refinements were carried out with the SDP program.⁹ All four structures were already approximately known from the powder data, as will be discussed further below, and therefore the positional parameters of these structure models were used as starting parameters for the full-matrix least-squares refinements using atomic scattering factors, 10 corrected for anomalous dispersion.¹¹ Parameters accounting for isotropic secondary extinction were optimized as least-squares parameters. The weighting schemes accounted for the counting statistics.

Occupancy parameters were refined for all atomic positions with fixed scale factors together with the thermal parameters. Most atomic positions were found to be fully occupied, and the distinction between most nickel and silicon positions could easily be made not only by their respective atomic environments but also on the basis of the refined occupancy parameters (Table 2). In the final least-squares cycles these atomic positions were refined with the ideal occupancy values.

Figure 1. The distributions of nickel atoms at the positions 2*a* (0, 0, $1/4$) and 4*e* (0, 0, *z*) on the 6₃ axes of the lanthanum nickel silicides. As an example, the interatomic distances (pm) of $La₂₁Ni_{11-x}Si₁₅$ are indicated at the left-hand side of the figure. The occupation of two positions with interatomic distances <220 pm was considered as not possible. The translation periods *c*′ at the right-hand side of the columns correspond to hypothetical models for occupied (filled) and unoccupied sites (open circles). The ratios of nickel atoms occupying the positions 2*a* and 4*e* are shown at the top of the figure; the resulting maximum number of nickel atoms per translation period *c* is indicated at the bottom.

The only difficulties arose with the atomic positions (0, 0, $\frac{1}{4}$ and 0, 0, *z*) located on the 6₃ axes with the Wyckoff notations 2*a* and 4*e* (Figure 1). Both of these sites were found to be occupied, but because the translation period *c* is rather short in all of these structures (∼435 pm), these positions cannot be fully occupied for steric reasons. The atomic environments of these positions are similar to those of the nickel and silicon atoms. The question which of the two should be favored was dealt with at length in a recent publication¹² on the closely related structures of $Nd_{42}Ni_{22-x}Si_{31}$ and $Nd_6Ni_{2-x}Si_3$, considering

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⁽⁹⁾ Frenz, B. A., and Associates Inc. and Enraf-Nonius. *SDP (Structure Determination Package)*, Version 3; College Station (Texas) and Delft (Holland), 1985.

⁽¹⁰⁾ Cromer, D. T.; Mann, J. B. *Acta Crystallogr.* **1968**, *A24*, 321.

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Table 2. Atomic Parameters of $La_6Ni_{2-x}Si_3$, $La_5Ni_{2-x}Si_3$, $La₁₅Ni_{7-x}Si₁₀$, and $La₂₁Ni_{11-x}Si₁₅^a$

atom	$P6_3/m$	occupancy	$\boldsymbol{\chi}$	у	Z	B_{eq}	CP						
$La_6Ni_{1.54(2)}Si_3$													
La1	6h	0.999(2)		$0.24140(5)$ $0.23084(5)$	$^{1/4}$	1.41(1)	a						
La ₂	6h	1.000(2)	0.52021(5)	0.13869(5)	$^{1/4}$	0.90(1)	b						
Ni1	4e	$0.094(4)*$	$\overline{0}$	$\mathbf{0}$	0.104(4)	$0.9*$	e						
Ni2	2c	0.994(7)	$\frac{1}{3}$	$^{2}/_{3}$	$^{1/4}$	1.08(3)	d						
Ni3	2a	$0.355(6)*$	$\overline{0}$	$\mathbf{0}$	$^{1/4}$	$0.9*$	f						
Si	6h	0.984(8)	0.1639(2)	0.4453(2)	$\frac{1}{4}$	1.01(4)	g						
$La5Ni1.75(1)Si3$													
La1	6h	1.001(2)	0.00996(4)	0.18316(5)	$^{1/4}$	1.46(1)	a						
La ₂	6h	1.001(2)	0.40055(4)	0.26433(4)	$^{1/4}$	0.85(1)	b						
La3	6h	1.001(2)	0.45525(4)	0.06803(4)	$^{1/4}$	0.82(1)	b						
La4	2c	0.999(4)	$\frac{1}{3}$	$^{2}/_{3}$	$\frac{1}{4}$	0.80(1)	c						
Ni1	6h	0.974(5)	0.2821(1)	0.4991(1)	$\frac{1}{4}$	0.93(3)	d						
Ni2	4e	$0.083(5)*$	0	$\mathbf{0}$	0.114(5)	$0.9*$	e						
Ni3	2a	$0.335(8)*$	$\overline{0}$	$\overline{0}$	$^{1/4}$	$0.9*$	f						
Si1	6h	0.97(1)	0.1677(2)	0.5522(2)	$^{1/4}$	0.93(5)	h						
Si ₂	6h	0.98(1)	0.2329(2)	0.3293(2)	$^{1/4}$	1.02(6)							
							g						
			$La_{15}Ni_{6.62(2)}Si_{10}$										
La1	6h	1.004(2)	0.13183(3)	0.14868(3)	$^{1/4}$	1.31(1)	a						
La ₂	6h	1.002(2)	0.32182(3)	0.12395(3)	$^{1/4}$	0.84(1)	b						
La3	6h	0.997(2)	0.35616(3)	0.32177(3)	$^{1/4}$	0.84(1)	b						
La4	6h	0.996(2)	0.50191(3)	0.08170(3)	$^{1/4}$	0.82(1)	b						
La5	6h	0.996(2)	0.53400(3)	0.28881(3)	$^{1/4}$	0.88(1)	c						
Ni1	6h	0.989(4)	0.15420(6)	0.39517(6)	$\frac{1}{4}$	0.91(2)	d						
Ni ₂	6h	0.998(4)	0.19972(6)	0.62056(6)	$\frac{1}{4}$	0.94(2)	d						
Ni3	4e	$0.156(4)$ *	0	$\boldsymbol{0}$	0.090(2)	$0.9*$	e						
Ni4	2a	$0.306(6)*$	$\overline{0}$	$\overline{0}$	$\frac{1}{4}$	$0.9*$	f						
Si1	6h	0.979(8)	0.0623(1)	0.2584(1)	$^{1/4}$	0.95(5)	g						
Si ₂	6h	0.978(8)	0.1103(1)	0.4851(1)	$\frac{1}{4}$	0.90(5)	h						
Si3	6h	0.976(8)	0.2899(1)	0.4448(1)	$^{1/4}$	0.97(5)	h						
Si4	$_{2c}$	0.99(1)	$\frac{1}{3}$	$^{2}/_{3}$	$^{1/4}$	0.77(6)	i						
			$La21Ni10.49(3)Si15$										
La1	6h	0.971(4)	0.10837(7)	0.12769(8)	$^{1/4}$	1.52(3)	a						
La ₂	6h	1.009(4)	0.26894(6)	0.11175(6)	$^{1/4}$	0.91(3)	b						
La3	6h	1.016(4)	0.29214(6)	0.27500(6)	$^{1/4}$	0.84(3)	b						
La4	6h	1.003(4)	0.42280(6)	0.08350(6)	$^{1/4}$	0.80(3)	b						
La5	6h	1.002(4)	0.44425(6)	0.25318(7)	$^{1/4}$	0.78(2)	c						
La6	6h	0.992(4)	0.57502(6)	0.05055(6)	$\frac{1}{4}$	0.79(3)	b						
La7	6h	1.005(3)	0.59675(8)	0.22312(8)	$^{1/4}$	0.78(2)	c						
Ni1	6h	1.002(8)	0.1173(1)	0.3272(1)	$^{1/4}$	0.92(6)	d						
Ni ₂	6h	0.963(9)	0.1498(1)	0.5117(1)	$\frac{1}{4}$	0.94(6)	d						
Ni3	6h	1.01(1)	0.3030(1)	0.4838(1)	$\frac{1}{4}$	0.92(7)	d						
Ni4	4e	$0.08(1)$ *	$\boldsymbol{0}$	$\boldsymbol{0}$	0.11(1)	$0.9*$	e						
Ni5	2c	0.97(1)	$\frac{1}{3}$	$^{2/3}$	$^{1/4}$	0.64(8)	d						
Ni ₆	2a	$0.34(2)$ *	0	$\boldsymbol{0}$	$\frac{1}{4}$	$0.9*$	f						
Si1	6h	0.98(2)	0.0432(3)	0.2123(4)	$^{1/4}$	1.2(2)							
Si ₂	6h	1.05(2)	0.0772(3)	0.3987(3)	$^{1/4}$	0.5(1)	g h						
Si3	6h	0.95(2)	0.1117(3)	0.5848(3)	$\frac{1}{4}$	0.8(1)	h						
Si4	6h	0.93(2)	0.2318(3)	0.3733(3)	$\frac{1}{4}$	0.8(1)	h						
Si5	6h	1.03(2)	0.2618(4)	0.5527(4)	$\frac{1}{4}$	1.0(1)	i						

^a The positional parameters have been standardized with the program STRUCTURE TIDY.¹⁴ The third column contains occupancy values which had been obtained in previous least-squares cycles. In the last cycles the ideal occupancy values (1.0) were assumed with the exception of those marked with asterisks. All atoms were refined with ellipsoidal displacement parameters. The table lists the equivalent isotropic values B_{eq} ($\times 10^4$ pm²), where $B_{eq} = (4/3)[a^{*2}B_{11} + b^{*2}B_{22} + c^{*2}B_{33} + a^{*}b^{*}$
 $\cos \nu B_{12} + a^{*}c^{*} \cos \beta B_{12} + b^{*}c^{*} \cos \alpha B_{21}$. The only exceptions cos *γ* B_{12} + a ^{*}*c*^{*} cos $β$ B_{13} + b ^{*}*c*^{*} cos α B_{23}]. The only exceptions occur for those atoms where the occupancy parameters were refined in the last cycles; for these atoms the isotropic displacement parameters (marked with asterisks) were held constant. The last column indicates the coordination polyhedra CP shown in Figure 3.

interatomic distances, occupation factors resulting from refinements with nickel or silicon atoms at these positions, and chemical composition as determined by energy dispersive X-ray fluorescence analyses. All of these arguments favored the occupancy of the 2*a* and 4*e* sites with nickel atoms. This is also the case for the present four structure determinations. Certainly the occupancy of these two sites solely with silicon atoms is not possible, because not more than two silicon atoms

can be placed on the $6₃$ axis within one translation period for steric reasons; and when we refined these positions with the scattering factors for silicon atoms, the total occupancies for these sites were all greater than 2: 2.39(6), 2.22(8), 2.77(6), and 2.2(2) for La₆Ni_{2-x}Si₃, La₅Ni_{2-x}Si₃, La₁₅Ni_{7-x}Si₁₀, and $\text{La}_{21}\text{Ni}_{11-x}\text{Si}_{15}$, respectively. Furthermore, even if only two silicon atoms were placed on the $6₃$ axis (an idealized situation with full occupancy of the 2*a* position and a nonoccupied 4*e* position) the silicon atoms in the resulting silicon chain would be only 218 pm apart (one-half of the translation period *c*). This distance may be compared to the considerably greater Si-Si distance of 235.2 pm in the diamond modification of elemental silicon.13 Hence, the occupation of the 2*a* and 4*e* sites solely by silicon atoms can be ruled out for these compounds. A mixed Ni/Si occupancy seems to be possible; however, for simplicity and in analogy with our previous work¹² on $Nd_{42}Ni_{22-x}Si_{31}$ and $Nd₆Ni_{2-x}Si₃$ we refined the 2*a* and 4*e* sites with the scattering factors of nickel atoms in the final refinement cycles. These resulted in the total occupancies of $1.09(3)$, $1.00(3)$, $1.24(3)$, and 0.99(8) nickel atoms on the two sites per cell of the four compounds $La_6Ni_{1.54(2)}Si_3$, $La_5Ni_{1.75(1)}Si_3$, $La_{15}Ni_{6.62(2)}Si_{10}$, and $La₂₁Ni_{10.49(3)}Si₁₅$, respectively. Since the occupancy of the 2*a* site was found to be higher than that of the 4*e* site, the atom distributions are expected to be similar to those shown in the two right-hand columns of Figure 1. The atomic parameters and interatomic distances are summarized in Tables 2 and 3 and further detailed in the Supporting Information.

Discussion

Of the two new compounds reported here, $La_{21}Ni_{11-x}Si_{15}$ crystallizes with a new structure type (Figure 2), while $\text{La}_{15}\text{Ni}_{7-x}\text{Si}_{10}$ is isotypic with $\text{Pr}_{15}\text{Ni}_{7}\text{Si}_{10}$.⁴ As mentioned above,
the other two compounds Le Ni Si and Le Ni Si have the other two compounds, $La₅Ni_{2-x}Si₃$ and $La₆Ni_{2-x}Si₃$, have already been reported. However, in contrast to these earlier structure determinations from film data,^{1,3} we find ordered distributions of the nickel and silicon atoms in these compounds. The four structures are closely related, and they contain the same coordination polyhedra (Table 2 and Figure 3).

As an example for these four structures we will discuss that of $La₂₁Ni₁₁Si₁₅$ in more detail, since it represents a new structure type. With the exception of the nickel atoms on the Wyckoff position 4*e* (Figure 1), all atoms are located on mirror planes, which are oriented perpendicular to the hexagonal axis. The lanthanum atoms form trigonal prisms which share all of their trigonal faces and most of the rectangular faces with adjacent trigonal lanthanum prisms. The nickel and silicon atoms are located inside these trigonal prisms.

The lanthanum atoms have three different kinds of environments, designated **a**, **b**, and **c** in Figure 3, with 15 (10 La $+2$ $Ni + 3 Si$, 17 (10 La + 2 Ni + 5 Si), and 20 (8 La + 6 Ni + 6 Si) nearest neighbors. The coordination polyhedron **a** occurs for the La1 atoms. It contains the nickel atoms Ni4 and Ni6 of the positions $4e$ and $2a$, which are located on the $6₃$ axes and which are only partially occupied. Most frequently this coordination polyhedron will contain two of these nickel atoms, and occasionally it will contain one. Within the coordination polyhedra of the lanthanum atoms the La-Si interactions are probably the most important ones, as is reflected by the interatomic distances, which correlate with the coordination numbers. The average La-Si distances are rather short for the La1 atom with 311.6 pm and three silicon neighbors. For the La2, La3, La4, and La6 atoms, which have five silicon

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^a All distances shorter than 490 pm (La-La), 380 pm (La-Ni, La-Si, Ni-Si, Si-Si), and 330 pm (Ni-Ni) are listed. Standard deviations are all less than 0.7 pm. The polyhedra of the La1 atoms of all four structures contain the nickel atoms of the partially occupied sites on the 63 axes which are marked with asterisks. For steric reasons only one or two of these nickel sites can be occupied at the same time.

Figure 2. Projection of the La₂₁Ni_{11-x}Si₁₅ structure along the hexagonal axis. The numbers inside the circles represent the atom designations of the lanthanum atoms. The other atom designations in the lower left-hand and upper right-hand parts of the outlined cell correspond to the nickel and silicon atoms, respectively. In the right-hand part of the figure the trigonal prisms of lanthanum atoms surrounding the nickel and silicon atoms are emphasized.

neighbors, they are longer: 321.1, 319.7, 319.5, and 321.2 pm, respectively. And for the La5 and La7 atoms with six silicon neighbors they are the longest: 321.5 and 322.4 pm, respectively. The La-Ni interactions are certainly also bonding: the

Figure 3. Coordination polyhedra occurring in the structures of La₆- $Ni₂Si₃$, La₅Ni₂Si₃, La₁₅Ni₇Si₁₀, and La₂₁Ni₁₁Si₁₅. The symbols $a-i$ correspond to the atom designations as indicated in Table 2. All coordination polyhedra contain mirror planes, which are oriented approximately perpendicular to the projection directions. The nickel positions on the $6₃$ axes are designated with asterisks. Not all of these partially occupied positions are shown, but all corresponding interatomic distances are listed in Table 3.

corresponding distances cover the range between 300.2 and 330.6 pm for the La2-La7 polyhedra, where all nickel positions are fully occupied. The La-La distances extend between 362.1 and 435.2 pm. In view of the large lanthanum content of the compound and considering that most of these distances are similar to the average La-La distance of 375.4 pm in elemental lanthanum,15 the La-La interactions will also contribute to the stability of the compounds.

Most nickel atoms are situated in a trigonal prism of lanthanum atoms with three silicon atoms outside the rectangular faces of that prism, thus increasing the coordination number to 9 (polyhedron **^d** of Figure 3). The Ni-Si distances are all rather short. They vary between 233.9 and 244.8 pm. These values are only slightly greater than the sum of the single-bond radii (232.7 pm) for silicon (117.3 pm) and nickel (115.4 pm) given by Pauling.¹⁶ The Ni4 and Ni6 atoms of $\text{L}a_{21}\text{Ni}_{11-x}\text{Si}_{15}$ are situated on the 63 axis at the 4*e* and 2*a* positions, which cannot be fully occupied as already discussed. They have octahedral and tricapped trigonal prismatic lanthanum coordination with additional nickel atoms above and below (coordination polyhedra **e** and **f** in Figure 3). At first sight the coordination polyhedron **f** of the Ni6 atoms seems to violate the "waistcontact-restriction rule", which states that transition metal atoms located in trigonal prisms of rare earth atoms should not have contact to rare earth or transition element atoms outside the rectangular faces of the prisms.¹⁷ However, this rule is only applicable for trigonal prisms which are elongated along the trigonal axis, as is usually the case.17,18 In contrast, the trigonal prisms of the lanthanum atoms in the coordination polyhedron **f** are compressed with an average *w/s* ratio (as defined by Parthe´ et al.17) of ∼0.87 in the four compounds, and therefore the waistcontact-restriction rule does not apply here.

The silicon atoms are also located in trigonal prisms formed by rare earth atoms with one nickel and two rare earth, two

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nickel and one rare earth, or with three nickel atoms outside the rectangular faces of the trigonal rare earth prisms (coordination polyhedra **g**, **h**, and **i** of Figure 3).

The crystal structures of the compounds with the idealized formulas $La₆Ni₂Si₃$, $La₅Ni₂Si₃$, $La₁₅Ni₇Si₁₀$, and $La₂₁Ni₁₁Si₁₅$ reported here belong to a large family of structures with a metal: metalloid ratio close to or exactly 2:1. Most of these are ternary compounds with two kinds of metal atoms: large, electropositive metals, e.g., lanthanoids, actinoids, and early transition elements, which we designate with the letter *R* in the present paper, and late transition metals, here designated with *T*. The most common metalloids *M* are silicon and phosphorus.^{7,12,17-29} In all of these structures almost all atoms are located on two mirror planes, which extend perpendicular to the short translation period, and almost all metalloid atoms are situated in trigonal prisms formed by the *R* and/or *T* atoms.

In the lanthanum nickel silicides characterized here, not only all silicon but also most of the nickel atoms are surrounded by lanthanum atoms. These trigonal prisms are all oriented parallel to each other, and they share most of their rectangular faces, thus forming larger triangular prismatic building blocks, which are emphasized in Figure 4, where they appear as large triangles in the projections along the hexagonal axes. Each hexagonal cell has two of these triangular building blocks, which are shifted relative to each other in the ζ direction by half a translation period. The edges of the triangles forming the cross sections of the triangular building blocks consist of $n = 2, 3, 4$, and 5 lanthanum triangles in the compounds $La₆Ni₂Si₃$ (idealized cell content: La₁₂Ni₄Si₆), La₅Ni₂Si₃ (La₂₀Ni₈Si₁₂), La₁₅Ni₇Si₁₀ (La₃₀- $Ni₁₄Si₂₀$), and $La₂₁Ni₁₁Si₁₅ (La₄₂Ni₂₂Si₃₀)$, respectively. The general formula for these compounds is $R_{(n+1)(n+2)}$ $Ni_{n(n-1)+2}Si_{n(n+1)}$. The most simple compound of this series "La₃NiSi" with $n =$ 1 is not known; however, the corresponding structure has been reported for the binary compound with the idealized formula $Er₃Ru₂$ by Fornasini and Palenzona.³⁰

Figure 4 also shows another series of hexagonal structures formed by thorium or uranium as the *R* component, late transition elements as the *T* component, and phosphorus as the component *M*. The examples chosen for our figure are $Ni₂P³¹$ with Fe₂P type structure, $Th_2Ni_{12}P_7^{32}$ and $U_2Ni_{12}P_7^{33,34}$ with Zr_2 - $Fe_{12}P_7$ structure,³⁵ Th₆Ni₂₀P₁₃³² and U₆Ni₂₀P₁₃³⁶ with $Zr_6Ni_{20}P_{13}$

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 $R_{(n+1)(n+2)}T_{n(n-1)+2}M_{n(n+1)}$

 $R_{n(n-1)}T_{(n+1)(n+2)}M_{n(n+1)+1}$

Figure 4. The compounds of two related structural series with the general formulas $R_{(n+1)(n+2)}T_{n(n-1)+2}M_{n(n+1)}$ and $R_{n(n-1)}T_{(n+1)(n+2)}M_{n(n+1)+1}$. Large open circles: La, Th, or U. Small open circles: Co or Ni. Filled circles: Si or P. The letter *n* of the general formulas indicates the number of joined trigonal prisms along one of the basal edges of the trigonal building blocks.

structure,³⁷ Th₁₂Ni₃₀P₂₁³² with a structure first described for $(La, Ce)_{12}Rh_{30}P_{21}$,³⁸ and the two unpublished phosphides Th₂₀- $Co_{42}P_{31}$ and $U_{20}Ni_{42}P_{31}.^{39}$ This series of phosphides was recognized earlier;^{21,22} however, few examples were known at that time, and in some of these examples the positions at the 6_3 axis $(0, 0, z)$ were reported as unoccupied.⁴⁰ The general formula of this series is $R_{n(n-1)}T_{(n+1)(n+2)}M_{n(n+1)+1}$. It can be seen that this formula is similar to the formula

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 $R_{(n+1)(n+2)}T_{n(n-1)+2}M_{n(n+1)}$ given above for the series of lanthanum nickel silicides. The major difference between the two series results from the fact that most positions of the *R* and *T* atoms in the two series are interchanged (disregarding differences in the heights *z* of the projection direction, as discussed in the next paragraph). A minor difference is due to the occupancy of the sites $0, 0, z$ at the $6₃$ (or 6) axes. In the silicide series the formula results from the assumption that no more than two *T* (nickel) atoms of the cell content can be situated at the positions 0, 0, *z*, whereas in the formula for the phosphides no more than one *M* (phosphorus) atom can occupy these positions. This difference results from the fact that the condensed trigonal prisms forming the major part of the cell content are composed of the (large) *R* atoms in the silicides and of the (small) *T* atoms in the phosphides. Hence, the

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Table 4. Systematics of Hexagonal Structures with Metal:Metalloid Ratios Close to 2:1*^a*

$P6m2 \t1$ 101	201 P6m2 4	301 P6m2 9	401 P6m2 16	501 P6m2 25	601 P6m2 36	701 P6m2 49	
WC (45) BaPtSb (46)	α -UCr ₆ P ₄ (47)	$Gd_4Co_{13}(Si, P)_{9}(42)$ $UMo_{13}P_9$ (48)	$Ce_9Ni_{26}P_{12}b(49)$	$Tb_{16}Ni_{36}P_{22}b_{29}$ $U_9Co_{37}Si_{25}$ (7)	$\text{Tb}_{25}\text{Ni}_{49}\text{P}_{33}$ b(29)	$R_{36}T_{61}M_{49}$	$R_{(n-1)}^2 T_{n(n+2)-2} M_{n^2}$
111 P62m 3 $Fe2P$ (31) R_3 TM $Fe2P$ (31)	211 P6 $\overline{7}$ $Cr_{12}P_7$ (50, 51) $Ce_6Ni_2Si_3$ (3) Zr ₂ Fe ₁₂ P ₇ (35) $T_{14}M_7$	311 P6 13 $Rh_{20}Si_{13}$ (52) $Ce5Ni2Si3$ (1) $Zr_6Ni_{20}P_{13}$ (37) $R_2T_{24}M_{13}$	411 PC 21 $T_{30}M_{21}$ $Pr_{15}Ni_7Si_{10}$ (4) (La, Ce) ₁₂ Rh ₃₀ P ₂₁ (38) U ₂₀ Ni ₄₂ P ₃₁ $R_6T_{36}M_{21}$ $Zr_2Ni_{12}P_7$ (53)	511 P6 31 $T_{42}M_{31}$ $La21Ni11Si15$ (54) (39) $R_{12}T_{50}M_{31}$	611 P6 43 $T_{56}M_{43}$ $R_{56}T_{32}M_{42}$ Tb ₁₅ Ni ₂₈ P ₂₁ (40) $Ho_{20}Ni_{66}P_{43}$ (55)	711 P6 57 $T_{72}M_{56}$ R ₇₂ T ₄₄ M ₅₆ $R_{42}T_{72}M_{57}$ $R_{30}T_{84}M_{57}$ La ₆ Rh ₃₂ P ₁₇ (56)	$T_{(n+1)(n+2)}M_{n(n+1)+1}$ $R_{(n+1)(n+2)}T_{n(n-1)+2}M_{n(n+1)}$ $R_{n(n-1)}T_{(n+1)(n+2)}M_{n(n+1)+1}$ $R_{n(n-3)+2}T_{n(n+5)}M_{n(n+1)+1}$
	221 P62m 12 $Hf_2Co_4P_3$ (57) $Sc_5Co_{19}P_{12}(58)$	321 P6 19 $Yb_6Co_{30}P_{19}$ (43) $U_2Cr_{30}P_{19}$ (41, 48) $Tm_{13}Ni_{25}As_{19}$ (59)	421 P6 28	521 P6 39 U_6 Co ₃₀ Si ₁₉ (60)	621 P6 52	721 P6 67 $U_{10}Co_{51}Si_{33}$ (61)	
SG К hk1		331 P62m 27	PÕ 431 37	531 P6 49 U_6 Mo ₇₄ P ₄₉ (41, 44)	631 P6 63	731 P6 - 79	
Formula (Ref.) $K = h^2 + hk + k^2$			441 P62m 48	541 P6 61 Nd ₄₂ Ni ₂₂ Si ₃₁ (12)	641 P6 -76	741 P6 93	

^a For each compound the formula is listed together with the reference number (in parentheses), the *hkl* value of the strongest reflection in a powder diagram (besides the reflection 002), the space group (SG), and the corresponding *K* value as defined in the legend in the lower left-hand corner of this table. The general formulas of the series are listed in the last column. ^{*b*} The formulas Ce₉Ni₂₆P₁₂,⁴⁹ Tb₁₆Ni₃₆P₂₂,²⁹ and Tb₂₅Ni₄₉P₃₃²⁹ were given in the original publications. According to the structural systematics the ideal formulas are $Ce_9Ni_{22}P_{16}$, $Tb_{16}Ni_{33}P_{25}$, and $Tb_{25}Ni_{46}P_{36}$, respectively.

Figure 5. The lattice constants and the indices of the strongest reflections of hexagonal structures with a metal:metalloid ratio close to 2:1. The metalloid atoms (filled circles) form a hexagonal sublattice with the cell constant a_0 . The cell constant of the real hexagonal cell is defined by the equation $a = a_0 K^{1/2}$, where $K = h^2 + hk + k^2$ and where *h* and *k* are at the same time the indices of the strongest reflection *hk*1. *K* also equals the number of metalloid atoms in the hexagonal cell of the ideal structures. Occasionally some of the metalloid positions are occupied by late transition metal atoms, and sometimes a few metal positions are unoccupied. In the latter case these positions are indicated by the symbol \Box .

translation period *c* is greater in the silicides than in the phosphides. In reality there are fewer than two nickel atoms (but more than one) per translation period on the 6-fold axis in the silicides, as was discussed above.

The structures of the two series of Figure 4 were drawn emphasizing the similarities. There is another major difference between the two series. At first sight it may seem that the same atomic positions are occupied in the two series. This, however, is not the case. In the series of silicides on the left-hand side of the figure, the atoms (Ni and Si) filling the condensed trigonal prisms formed by the lanthanum atoms are at the same height of the projection direction. In each half of the hexagonal cell they form a hexagonal net similar to the net of B atoms in the AlB_2 type structure. In contrast, the *R* and phosphorus atoms occupying the condensed trigonal prisms of *T* atoms in the phosphide series are alternating in height with $\Delta z = \frac{1}{2}$.

Most of the X-ray powder patterns of the compounds shown in Figure 4 show two very strong diffraction lines. One is the reflection 002, and this is readily rationalized, since almost all atoms of these compounds are situated on two mirror planes, which are oriented perpendicular to the hexagonal c axis at $z =$ 0 and $z = \frac{1}{2}$ or at $z = \frac{1}{4}$ and $z = \frac{3}{4}$. Hence, for the reflection 002 almost all atoms scatter in phase. The indices of the other strong reflection have been recognized empirically to be related to the size of the hexagonal cell by several authors.19,29,41 This is shown in Figure 5 using $Gd_4Co_{13}(Si, P)_9$,⁴² $Zr_6Ni_{20}Si_{13}$,³⁷ and $Yb_6Co_{30}P_{19}^{43}$ as examples, where the indices of these strongest reflections are 301, 311, and 321, respectively. Generally, the index *l* of these reflections is always 1, while the indices *h* and *k* can be extracted from the unit cell in a manner as is shown in Figure 5. The lattice constant *a* is also related to these *h* and *k* values. It is defined by the equation $a = a_0 K^{1/2}$, where $K = h^2 + hk + k^2$. The value *K* is at the same time the number of atoms situated in the centers of the trigonal prisms formed by the metal atoms. In the examples of Figure 5 the values of *K* are 9, 13, and 19 phosphorus (silicon) atoms, respectively. These atoms form a hexagonal sublattice with a_0 as the translation period. The reader may choose the phosphide Th_{20} - $Co_{42}P_{31}^{39}$ ($Z = 1$) of Figure 4 as another example. It can be extracted from that figure that $h = 5$ and $k = 1$. Hence, the strongest reflection of the type *hk*1 in the powder diagram has the indices 511, and there are $K = 5^2 + (5)(1) + 1 = 31$ phosphorus atoms in the cell.

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As examples for the calculation of the lattice constants *a* from the subcell lattice constant a_0 we take the series of the phosphides shown in Figure 4: $Ni₂P (Ni₆P₃)$, $Th₂Ni₁₂P₇$, $Th₆$ - $Ni_{20}P_{13}$, $Th_{12}Ni_{30}P_{21}$, and $Th_{20}Co_{42}P_{31}$, where $K = h^2 + hk +$ k^2 equals 3, 7, 13, 21, and 31, respectively. The average a_0 of the hexagonal subcell of these phosphides is close to 360 pm, and the lattice constants *a* calculated from the relation $a = a_0$ $K^{1/2}$ are 952, 1297, 1649, and 2004 pm, as compared to the observed values 911, 1281, 1669, and 2060 pm. The analogous relationship exists also for the series of lanthanum nickel silicides of Figure 4: $La₆Ni₂Si₃$ (cell content $La₁₂Ni₄Si₆$), $La₅$ - $Ni₂Si₃ (La₂₀Ni₈Si₁₂), La₁₅Ni₇Si₁₀ (La₃₀Ni₁₄Si₂₀), and La₂₁Ni₁₁ Si_{15}$ (La₄₂Ni₂₂Si₃₀). For these compounds the number of silicon atoms per cell is $K - 1$, since the small atoms at the positions 0, 0, ζ are nickel instead of silicon atoms. The average a_0 of the hexagonal subcell of these silicides is close to 445 pm, and the lattice constants *a* calculated from the relation $a = a_0 K^{1/2}$ are 1177, 1604, 2039, and 2478 pm as compared to the observed values 1224, 1624, 2021, and 2428 pm. In both the phosphide and the silicide series there are systematic differences between the calculated and observed lattice constants *a*. These result from the varying Th:Ni and La:Ni ratios, respectively. If these are taken into account, the agreement is much better, and in fact the powder patterns of the compounds of $U_4Mo_{37}P_{25}$,⁴¹ U_6 - $\rm Mo_{60}P_{39}, ^{41,44}U_{12}Mo_{102}P_{67}, ^{41,44}U_{6}Mo_{74}P_{49}, ^{41,44}$ and $\rm U_{20}Ni_{42}P_{31}{}^{39}$ have been indexed on the basis of such structural systematics. Subsequently the predicted structures of $U_6Mo_{74}P_{49}$ and U_{20} - $Ni_{42}P_{31}$ were refined from single-crystal^{41,44} and powder diffractometer data,39 respectively. Similarly, the model for the successfully refined structure of the presently reported silicide $La₂₁Ni₁₁Si₁₅$ was proposed by extrapolation of the recognized structural relationships shown in Figure 4.

Another regularity concerns the occupancy of the site 2*c* $(1/3, 2/3, 1/4)$ of the silicide series $R_{(n+1)(n+2)}T_{n(n-1)+2}M_{n(n+1)}$ and the corresponding site in the phosphide series $R_{n(n-1)}T_{(n+1)(n+2)}M_{n(n+1)+1}$ of Figure 4. In the silicide series this site is occupied alternatingly with Si, Ni, La, Si, Ni, La... atoms for $n = 1, 2, 3, 4, 5, 6...$, while in the phosphide series the corresponding sites are occupied by P, Th, Ni, P, Th, Ni... atoms, respectively.

In Table 4 we have made an attempt to list all hexagonal structures which follow those structural systematics, which we have discussed above with the aid of Figure 5. The examples shown in Figure 4 are listed in lines 5 and 6 of that table. In the last column of that table the general formula is listed for those series where more than one example is known. The other examples, e.g., $UMo_{13}P_9^{41,49}$, $U_9Co_{37}Si_{25}$,⁷ $Zr_2Cr_{12}P_7$,⁵³ or La_6 - $Rh_{32}P_{17}$,⁵⁶ belong to structural series where there is only one

representative, and we have not attempted to list the general formula. The only exception is the series with $\text{Ho}_{20}\text{Ni}_{66}\text{P}_{43}^{55}$ as example, for which Kuz'ma and Chykhrii²³ have already given a general formula and the compositions of the hypothetical examples.

The space groups of the compounds listed in Table 4 also show some systematics. The compounds listed in lines 2 and 3 have the reflection *h*01 as a very strong reflection, and their space group is *P6m2*. The compounds with the very strong reflections *hh*1 all crystallize with the space group *P*62*m*. Finally all other compounds are listed here with the space group *P*6. This space group is correct when the atoms at the positions 0, 0, *z* are fully ordered. Frequently this is not the case, and then these structures are better refined in the space group $P63/$ m . This has been discussed in detail elsewhere.⁴³

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Supporting Information Available: Listings of the crystallographic data of La₆Ni_{2-*x*}Si₃, La₅Ni_{2-*x*}Si₃, La₁₅Ni_{7-*x*}Si₁₀, and La₂₁Ni_{11-*x*}Si₁₅ including anisotropic displacement parameters (Tables S1 and S2) (3 pages). Ordering information is given on any current masthead page.

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